## Application/Control No. Applicant(s)/Patent Under Reexamination 10/791,247 LIN, CHUN-HSIEN Notice of References Cited Art Unit Examiner Page 1 of 1 1746 Saeed T. Chaudhry **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,962,161	11-2005	Inoue et al.	134/34
*	В	US-2002/0083959	07-2002	Morita et al.	134/1.3
*	С	US-6,242,165	06-2001	Vaartstra, Brian A.	430/329
	۵	US-			
	Е	US-			
	щ	US-		·	
	G	US-			
	Ξ	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
·	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
·	Q					
	R					
	s					
	T.					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	8	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.